

SiC Power MOSFET Module

1200 V, 80 m Ω , 31 A Full Bridge Power Module

NVXK2PR80WXT2

Features

- DIP Silicon Carbide Full Bridge Power Module for On–Board Charger (OBC) for xEV Applications
- Creepage and Clearance per IEC60664-1, IEC 60950-1
- Compact Design for Low Total Module Resistance
- Module Serialization for Full Traceability
- Lead Free, ROHS and UL94V-0 Compliant
- Automotive Qualified per AEC-Q101 and AQG324

Typical Applications

• DC-DC and On-Board Charger in xEV Applications

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Value	Unit	
Drain-to-Source Voltage	V_{DSS}	1200	V	
Gate-to-Source Voltage		V_{GS}	+25/-15	V
Recommended Operation Values of Gate-to-Source Voltage, $T_J \le 1$	V_{GSop}	+20/-5	٧	
Continuous Drain Current (Note 1)	T _C = 25°C	I _D	31	Α
Power Dissipation (Note 1)		P_{D}	208	W
Pulsed Drain Current (Note 2)	$T_C = 25$ °C $t_p = 100 \mu s$	I _{DM}	153	Α
Single Pulse Surge Drain Current Capability	$T_{C} = 25^{\circ}C,$ $t_{p} = 10 \ \mu s,$ $R_{G} = 4.7 \ \Omega$	I _{DSC}	425	Α
Operating Junction Temperature		T_{J}	-55 to 175	°C
Storage Temperature	T _{stg}	-40 to 125	°C	
Source Current (Body Diode)	I _S	18	Α	
Single Pulse Drain-to-Source Avalanche Energy (Note 3)		E _{AS}	180	mJ

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

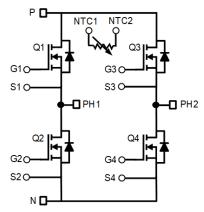
THERMAL CHARACTERISTICS (Note 1)

Parameter	Symbol	Тур	Max	Unit
Thermal Resistance Junction-to-Case (Note 1)	$R_{\theta JC}$	0.56	0.72	°C/W
Thermal Resistance Junction-to-Sink (Note 1)	$R_{\Psi JS}$	0.98	1.14	°C/W

- 1. Particular conditions specified determine thermal resistance values shown. Infinite heatsink with $T_C=100^{\circ}C$ for $R_{\theta JC}.$ For $R_{\Psi JS}$ assembled to 3 mm thick aluminum heatsink with infinite cooling bottom surface at 85°C, through 38 μm thick TIM with 6.5 W/mK thermal conductivity.
- Repetitive rating limited by maximum junction temperature and transconductance.
- 3. E_{AS} based on initial T_J = 25°C, L = 1 mH, I_{AS} = 19 A, V_{DD} = 120 V, V_{GS} = 18 V.

1

V _{(BR)DSS}	R _{DS(ON)} Max	I _D Max
1200 V	116 m Ω @ 20 V	31 A



SiC MOSFET Full Bridge Module

APM32 44.00x28.80x5.70 CASE MODHM

MARKING DIAGRAM

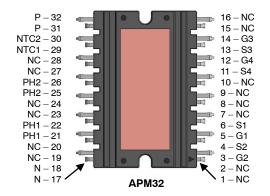
NVXK2PR80WXT2 ZZZ ATYWW NNNNNNN

NVXK2PR80WXT2 = Specific Device Code

ZZZ = Lot Number

AT = Assembly Site & Test Location

Y = Year W = Work Week NNN = Serial Number



ORDERING INFORMATION

Device	Package	Shipping
NVXK2PR80WXT2	APM32	10 ea / Tube

PIN DESCRIPTION

Pin No.	Pin Name	Description	
1, 2, 7, 8, 9, 10, 15, 16, 19, 20, 23, 24, 27, 28	NC	Not Connected pin	
3	G2	Q2 Gate	
4	S2	Q2 Source	
5	G1	Q1 Gate	
6	S1	Q1 Source	
11	S4	Q4 Source	
12	G4	Q4 Gate	
13	S3	Q3 Source	
14	G3	Q3 Gate	
17, 18	B-	Negative Power Terminal	
21, 22	PH1	Phase 1 Output	
25, 26	PH2	Phase 2 Output	
29	NTC1	NTC pin1	
30	NTC2	NTC pin2	
31, 32	B+	Positive Power Terminal	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise stated)

Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$		1200	_	-	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = 1 mA, referenced to	25°C	-	500	-	mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V	T _J = 25°C	-	_	100	μΑ
		V _{DS} = 1200 V	T _J = 175°C	_	_	1	mA
Gate-to-Source Leakage Current	I _{GSS}	$V_{GS} = +25/-15 \text{ V}, V_{DS} =$	0 V	_	_	±1	μΑ
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 5 \text{ mA}$		1.8	3	4.3	V
Recommended Gate Voltage	V_{GOP}			-5	_	+20	V
Drain-to-Source On Resistance	R _{DS(on)}	$V_{GS} = 20 \text{ V}, I_D = 20 \text{ A}, T_J = 25^{\circ}\text{C}$ $V_{GS} = 20 \text{ V}, I_D = 20 \text{ A}, T_J = 175^{\circ}\text{C}$		_	80	116	mΩ
				_	150	-	mΩ
Forward Transconductance	9FS	V _{DS} = 20 V, I _D = 20 A		_	11	_	S
CHARGES, CAPACITANCES & GATE RES	SISTANCE						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 800 V		_	1154	_	pF
Output Capacitance	Coss	1		_	79	_	1
Reverse Transfer Capacitance	C _{RSS}	1		_	7.9	_	1
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = -5/20 \text{ V}, V_{DS} = 600 \text{ V}, I_D = 20 \text{ A}$		_	56	-	nC
Threshold Gate Charge	Q _{G(TH)}			_	10	-	1
Gate-to-Source Charge	Q_{GS}			_	18	-	1
Gate-to-Drain Charge	Q_{GD}	1		_	11	-	1
Gate-Resistance	R_{G}	V _{GS} = 0 V, f = 1 MHz		-	1.2	-	Ω

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise stated) (continued)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
INDUCTIVE SWITCHING CHARACTERIS	TICS		•		•	
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = -5 / 20 \text{ V}, V_{DS} = 800 \text{ V},$	-	12	_	ns
Rise Time	t _r	$I_D = 20 \text{ A}, R_G = 4.7 \Omega,$ Inductive load	_	12	-	
Turn-Off Delay Time	t _{d(OFF)}		_	21	-	
Fall Time	t _f		_	9	-	
Turn-On Switching Loss	E _{ON}		_	135	-	μJ
Turn-Off Switching Loss	E _{OFF}		_	46	-	μJ
Total Switching Loss	E _{tot}		_	181	-	μJ
DRAIN-SOURCE DIODE CHARACTERIS	TICS					
Continuous Drain-Source Diode Forward Current (Notes 1)	I _{SD}	V _{GS} = -5 V, T _J = 25°C	-	_	31	А
Pulsed Drain-Source Diode Forward Current (Note 2)	I _{SDM}	$V_{GS} = -5 \text{ V}, T_J = 25^{\circ}\text{C}$	-	-	153	А
Forward Diode Voltage	V_{SD}	V _{GS} = -5 V, I _{SD} = 10 A, T _J = 25°C	_	3.9	-	V
Reverse Recovery Time	t _{RR}	$V_{GS} = -5 \text{ V}, \text{ dl}_{S}/\text{dt} = 1000 \text{ A}/\mu\text{s},$	-	16.2	_	ns
Peak Reverse Recovery Current	I _{RRM}	I _{SD} = 20 A	-	7.6	-	Α
Reverse Recovery Energy	E _{REC}		-	4.1	-	μJ
Reverse Recovery Charge	Q_{RR}	1	_	61.6	_	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse test: pulse width ≤300 µs, duty ratio ≤2%.

COMPONENTS

Component	Description	Туре	Quantity	Specification
NTC	10 kΩ, ±3%	Discrete	1	B Constants
	Case Size 0603			B _{25/50} : 3590
				$B_{25/85} = 3635$
				$B_{25/100} = 3650 \pm 3\%$

TYPICAL CHARACTERISTICS SIC MOSFET

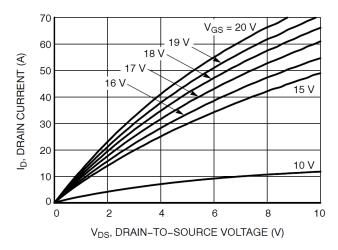


Figure 1. On-Region Characteristics

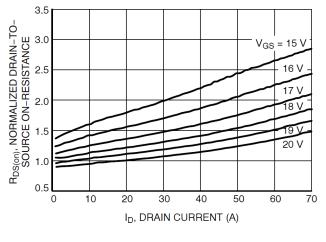


Figure 2. Normalized On–Resistance vs.
Drain Current and Gate Voltage

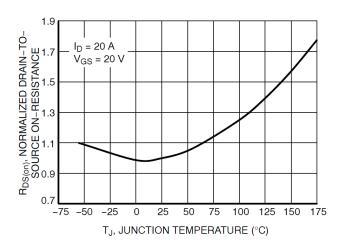


Figure 3. On–Resistance Variation with Temperature

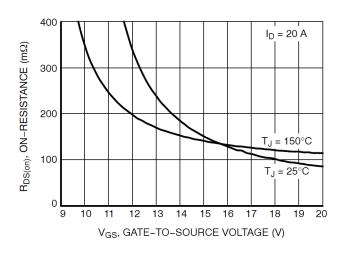


Figure 4. On-Resistance vs. Gate-to-Source Voltage

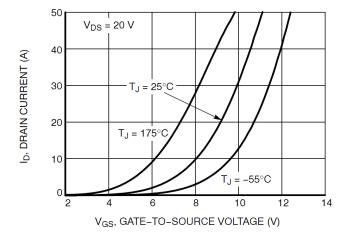


Figure 5. Transfer Characteristics

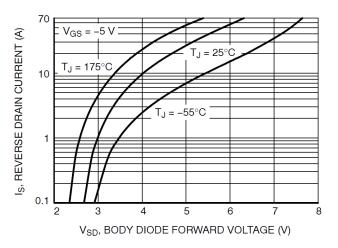


Figure 6. Diode Forward Voltage vs. Current

TYPICAL CHARACTERISTICS SIC MOSFET (continued)

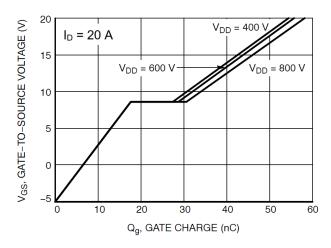


Figure 7. Gate-to-Source Voltage vs. Total Charge

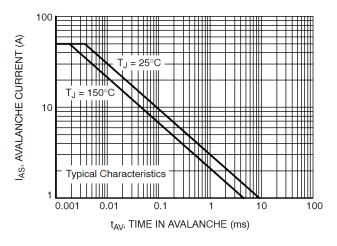


Figure 9. Unclamped Inductive Switching Capability

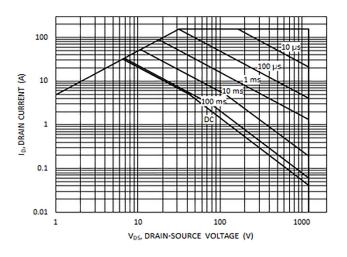


Figure 11. Safe Operating Area

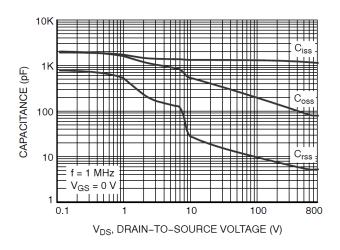


Figure 8. Capacitance vs. Drain-to-Source Voltage

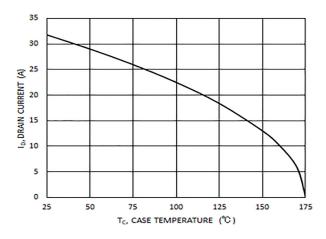


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

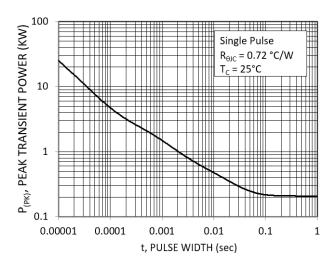


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (continued)

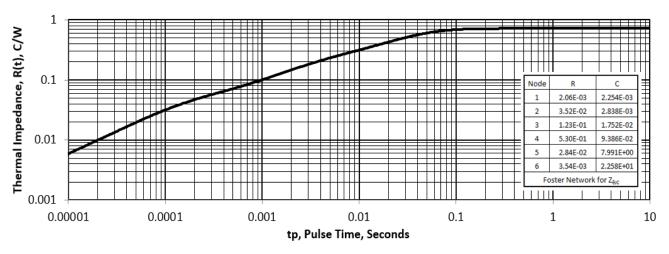


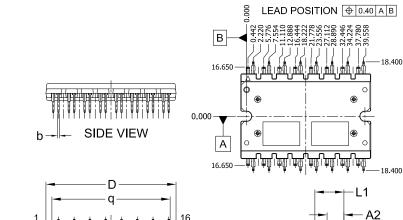
Figure 13. Thermal Response





APM32 44.00x28.80x5.70 CASE MODHM ISSUE A

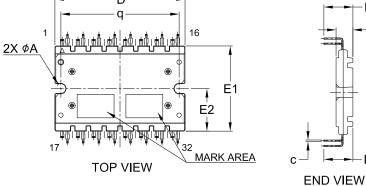
DATE 01 AUG 2023

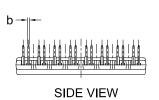


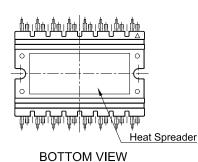
NOTES:

- 1. DIMENSIONING AND TOLERANCING PER. ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR EXTRUSIONS.

	MILLIMETERS				
DIM	MIN.	NOM.	MAX.		
A2	5.60	5.70	5.80		
b	0.50	0.60	0.70		
С	0.45	0.50	0.60		
D	43.80	44.00	44.20		
E1	28.60	28.80	29.00		
E2	14.25	14.40	14.55		
L1	9.50	9.80	10.10		
q	39.85	40.00	40.15		
ΦA	3.20	3.30	3.40		







GENERIC MARKING DIAGRAM*

XXXX = Specific Device Code

ZZZ = Lot ID

AT = Assembly & Test Location

Y = Year W = Work Week NNN = Serial Number *This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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